

## Communication

# Wafer-scale synthesis of monolayer WSe<sub>2</sub>: A multi-functional photocatalyst for efficient overall pure water splitting

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## ABSTRACT

A multi-functional photocatalyst, that can combine the catalytic functions of water oxidation and proton reduction together with light harvesting capacity, is highly desired for low cost, high efficiency, and highly stable solar fuel production. Monolayer WSe<sub>2</sub>, with a direct energy gap of  $\sim 1.65$  eV is a nearly ideal light absorber to convert sunlight to hydrogen fuels through solar water splitting. To date, however, the controlled synthesis of monolayer WSe<sub>2</sub> on a wafer scale and the realization of overall water splitting on WSe<sub>2</sub> have remained elusive. Here, we report the van de Waals epitaxy of crystalline monolayer WSe<sub>2</sub> on large area amorphous SiO<sub>x</sub> substrates. We have demonstrated, for the first time, the multi-functionality of monolayer WSe<sub>2</sub> in solar water splitting, including extraordinary capacities for efficient light harvesting, water oxidation, and proton reduction. The absorbed photon conversion efficiency exceeds 12% for a single monolayer WSe<sub>2</sub>. This work provides a viable strategy for wafer-scale synthesis of multi-functional photocatalysts for the development of efficient, low cost, and scalable solar fuel devices and systems.

## 1. Introduction

Solar water splitting, through the dissociation of water molecules to H<sub>2</sub> and O<sub>2</sub>, is one significant step of artificial photosynthesis to solve future energy and environmental issues [1,2]. Critical to the development of an efficient solar water splitting cell is the integration of catalysts, for water oxidation and/or proton reduction, with the semiconductor light absorber. For practical applications, it is also essential that the catalysts are of low cost and are earth-abundant. Si and III-V semiconductor materials [3–7] have been extensively studied for solar-to-fuel conversion due to the efficient light absorption. However, their operation often requires the use of expensive noble metal catalysts and their performance suffers from serious photo-corrosion [3,4]. Moreover, the substrates to grow III-V semiconductors are prohibitively expensive, and it is extremely difficult to integrate III-V semiconductor light absorbers on low cost foreign substrates, due to the lattice mismatch related issues [8–10]. Additionally, previously reported photocatalysts, such as CoO<sub>x</sub>, IrO<sub>x</sub>, Pt, MoS<sub>2</sub>, and RuO<sub>x</sub> are only capable of either oxidizing water [2,10–12] or proton reduction [13–16]. To efficiently

catalyze overall water splitting, the integration of dual catalysts with light absorbers is required. In such systems, charge carrier transport from the semiconductor light absorber to the catalyst is often hindered by the presence of impurities and/or potential barriers related to imperfect band alignment [17,18]. It has been envisioned that a multi-functional photocatalyst, that exhibit both catalytic and light harvesting capacities, can potentially address the challenges and performance bottlenecks of solar water splitting by minimizing the over-potential requirement, enhancing charge carrier transport and collection efficiency, and reducing the fabrication cost [2,10].

Recently, two-dimensional (2D) transitional metal dichalcogenides (TMDCs) have been intensively studied for electronic, optoelectronic, and solar energy device applications [19–23]. Among various TMDCs, monolayer WSe<sub>2</sub> has a direct bandgap of  $\sim 1.65$  eV and can absorb visible light efficiently while promising a relatively large photovoltage. Even for a single monolayer, 1–5% light [24,25] can be absorbed for photons with energy above the bandgap. Significantly, the energy band edges of monolayer WSe<sub>2</sub> can straddle water redox reactions [26–29]: its conduction band edge is positioned slightly more negative than the

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water reduction potential, while its valence band edge is located more positive than water oxidation potential and possess the capacity to drive oxygen evolution which is normally a bottleneck for water splitting. Previously,  $\text{WSe}_2$  was used as a photoanode in iodate electrolytes [30–32]. Recent studies have shown that monolayer TMDC provides catalytic sites [13,33–35] at edges for water redox reaction, which was not significant in bulk TMDC materials, and hydrogen evolution reaction through TMDC 2D materials has been intensively studied [16,33,36]. To date, however, there have been no reports on overall water splitting on monolayer or few layers  $\text{WSe}_2$ , and their capacity for water oxidation has remained largely unknown [34]. This has been limited, in part, by the lack of controlled synthesis of large area TMDC atomic crystals. Recently, significant efforts have been devoted toward the large area growth of TMDC monolayers using chemical vapor deposition (CVD) and physical vapor deposition (PVD) [19,23,37–39], but with limited success.

To achieve scalable, low cost solar water splitting devices and systems, it is highly desired to integrate TMDC catalysts on nonconventional substrates, such as amorphous  $\text{SiO}_x$  or metal substrates. In this work, by exploiting two-dimensional van der Waals (vdW) growth [21,29], we have investigated the molecular beam epitaxial (MBE) growth and structural, optical and photocatalytic characteristics of monolayer and multi-layer  $\text{WSe}_2$  directly on amorphous  $\text{SiO}_x$  templates. This is in direct contrast to previous MBE attempts of isolated TMDC flakes on crystalline substrates [29,40–43]. The vdW epitaxy of large area, uniform, and crystalline  $\text{WSe}_2$  on amorphous substrates is unambiguously supported by the streaky reflection high-energy electron diffraction (RHEED) pattern, a widely used technique to distinguish single crystalline, polycrystalline, and amorphous structures during epitaxy, and by detailed transmission electron microscopy (TEM) studies. The formation of uniform, continuous  $\text{WSe}_2$  monolayer on  $2''$   $\text{SiO}_x$  templates is further confirmed by detailed optical studies, including photoluminescence (PL) and Raman mapping. We have further demonstrated that, through the seamless integration of catalytic properties with light harvesting capacity, monolayer  $\text{WSe}_2$  can serve as a multi-functional photocatalyst and offer distinct advantages for solar water splitting, including significantly reduced over-potential, high efficiency, and stability.

## 2. Material and methods

### 2.1. Molecular beam epitaxial growth

$\text{WSe}_2$  monolayer, bilayer, and trilayer samples were grown on 250 nm  $\text{SiO}_x/\text{Si}$  substrates using a Veeco GENxplor MBE system. Prior to loading into the MBE chamber,  $\text{SiO}_x/\text{Si}$  substrates were first cleaned using acetone, methanol, and deionized water. During the growth of  $\text{WSe}_2$ , the substrate temperature was kept at  $\sim 400^\circ\text{C}$ . A standard effusion cell with PBN crucible and an e-beam evaporator are used for the thermal evaporation of Se and W sources, respectively. Se flux beam equivalent pressure was measured to be  $\sim 3.5 \times 10^{-7}$  Torr; and W deposition rate was  $\sim 0.16 \text{ \AA min}^{-1}$ . The growth rate was estimated to be  $\sim 0.7 \text{ \AA min}^{-1}$  and it took  $\sim 11$  min to synthesize one monolayer. Low substrate temperature and high selenium flux are chosen to ensure that tungsten atoms can be selenidized thoroughly. After growth with a desired thickness, substrate temperature was raised to  $650^\circ\text{C}$  for 10-min annealing with continuous Se flux.

### 2.2. Characterizations

Reflection high-energy electron diffraction (RHEED, Staib Instruments) was used to monitor the layer-by-layer growth of  $\text{WSe}_2$  nanostructures in situ. The beam acceleration voltage and filament current were set to 13.5 kV and 1.5 A, respectively. Micro-PL and micro-Raman studies were conducted using Renishaw inVia confocal Raman microscope with a 514 nm argon laser. The stoichiometric analysis was performed by X-ray photoelectron spectroscopy (XPS,

Thermo Scientific K-Alpha) with Al-K $\alpha$  monochromatic source ( $h\nu = 1486.6 \text{ eV}$ ) with a spot size of  $400 \mu\text{m}$ . The microstructure and morphology were characterized by optical microscope (Olympus MX40), atomic force microscope (AFM, Bruker Multimode), and transmission electron microscope (TEM, FEI Tecnai G<sup>2</sup> F20). TEM operated at 200 kV with a point resolution of 0.25 nm with a built-in EDX equipment (Oxford Instruments).

PMMA-assisted transfer method was used to prepare samples for TEM imaging. PMMA supporting layer for handling  $\text{WSe}_2$  film was first spin-coated on top of  $\text{WSe}_2$  sample on  $\text{SiO}_x/\text{Si}$  substrates at 3000 rpm for 30 s, followed by a curing process at  $160^\circ\text{C}$  for 10 min. PMMA-coated  $\text{WSe}_2$  sample was then diced into small pieces and immersed into 1 M KOH solution. After one hour, KOH solution etched  $\text{SiO}_x$  sublayer away making PMMA/ $\text{WSe}_2$  film peel off from substrate and float on etchant surface. Subsequently, the detached PMMA/ $\text{WSe}_2$  film was transferred into deionized water to remove etchant residues for several times. A TEM grid, or other substrates, was used to scoop it out from water surface. Then PMMA/ $\text{WSe}_2$  film on new substrate was baked at  $65^\circ\text{C}$  for two hours to enhance the adhesion. Finally, PMMA supporting layer was removed in acetone solution.

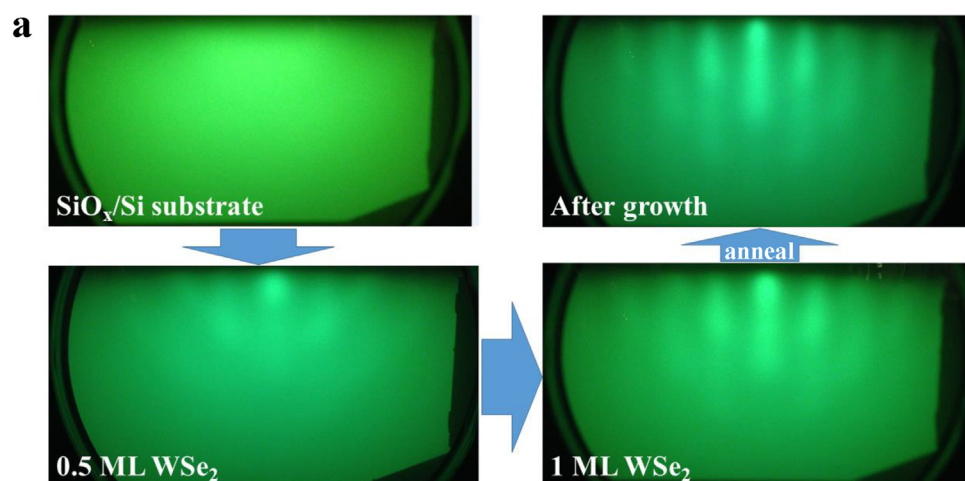
### 2.3. Solar water splitting measurements

$\text{WSe}_2$  monolayer samples were placed in a quartz chamber using polytetrafluoroethylene holders. 65 mL DI-water was added as reactant that had been pre-purged with argon gas for 30 min to remove the dissolved gases. Afterwards, the chamber was sealed with a transparent quartz cover by pumping down for 10 min. Before water splitting measurement, 1 mL gas sample was injected into a gas chromatograph machine (GC, Shimadzu, GC-8A) to ensure the chamber was in good vacuum. Then solar spectra ( $\sim 2200 \text{ mW cm}^{-2}$ ) from Xenon lamp with AM1.5G filter was irradiated onto  $\text{WSe}_2$  sample through the quartz lid, driving solar water splitting reactions on the surface of  $\text{WSe}_2$  monolayer. After every 15 min, gas production from water splitting was analyzed by injecting 1 mL gas sampling into GC using a SGE syringe with valves. For half reaction experiments with sacrificial reagents, 13 mL  $\text{CH}_3\text{OH}$  with 52 mL DI-water and 65 mL 3 mM  $\text{AgNO}_3$  solutions were added, respectively, for water reduction reaction with  $\text{H}_2$  generation and water oxidation reaction with  $\text{O}_2$  evolution.

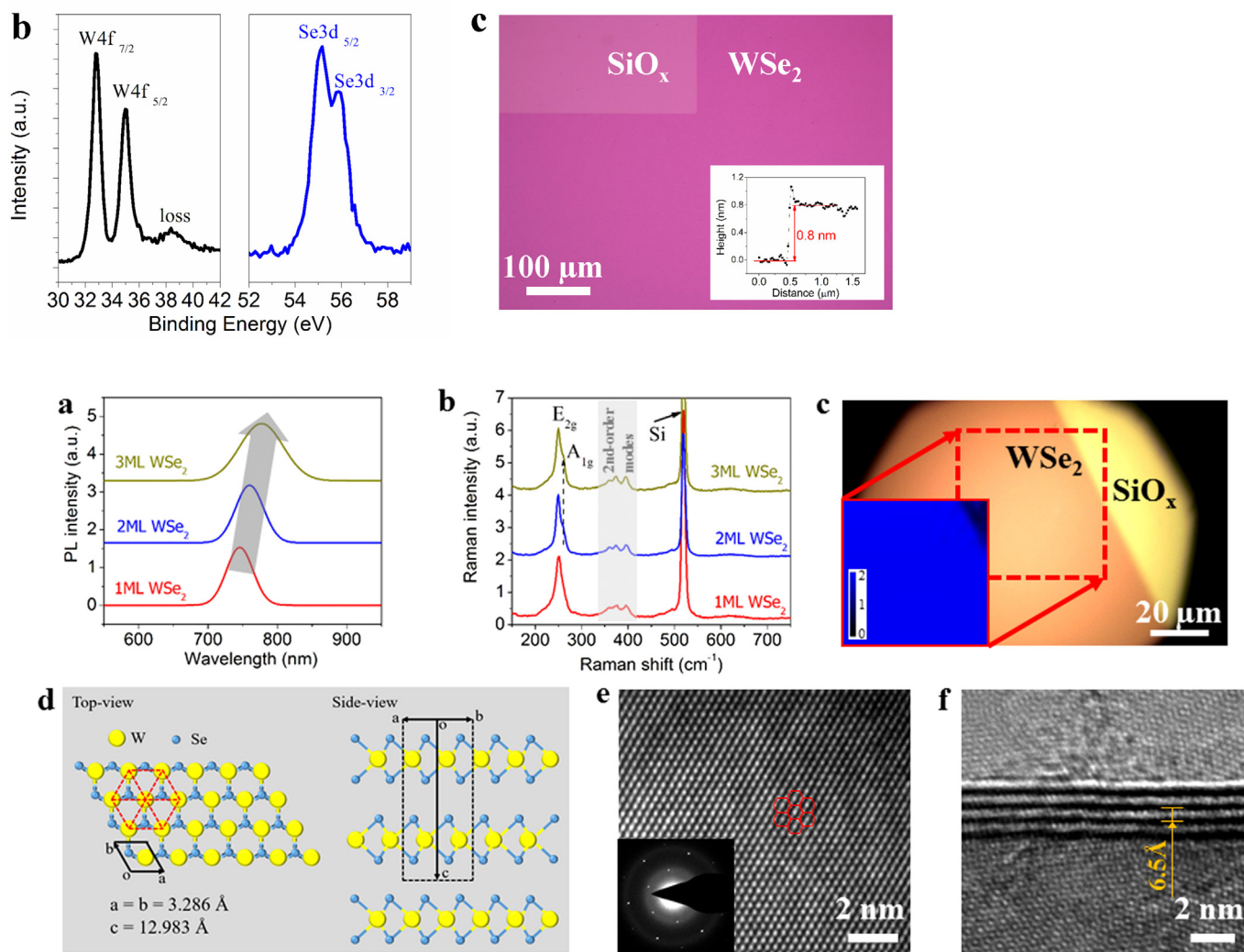
## 3. Results and discussions

2D  $\text{WSe}_2$  layers were grown on amorphous  $\text{SiO}_x$  substrates using a Veeco GENxplor MBE system (see Section 2.1). The observation of streaky RHEED feature during vdW growth of monolayer  $\text{WSe}_2$  film is shown in Fig. 1a, which provides unambiguous evidence for the achievement of crystalline  $\text{WSe}_2$  directly on amorphous substrates with atomically smooth surface. Similar streaky RHEED feature was reported for  $\text{WSe}_2$  epitaxy previously, but the growth took place on crystalline GaAs and graphite substrates [29,40–43]. Moreover, with the vdW interaction between  $\text{WSe}_2$  layers [23,29], multilayer  $\text{WSe}_2$  films can be directly synthesized on a wafer scale. Optical images of  $\text{WSe}_2$  grown on  $\text{SiO}_x$  are shown in Supplementary material Figs. S1 and S2 and RHEED observation of  $\text{WSe}_2$  grown on sapphire is displayed in Supplementary material Fig. S3. Stoichiometric analysis of epitaxial  $\text{WSe}_2$  was performed using high-resolution X-ray photoelectron spectroscopy (XPS), shown in Fig. 1b. The atomic percentage ratio of W and Se was measured to be  $\sim 1:2$ , suggesting the formation of nearly stoichiometric  $\text{WSe}_2$ . The absence of W and Se oxidation peaks confirms the high purity of epitaxial  $\text{WSe}_2$ . Elemental analysis of monolayer  $\text{WSe}_2$  was further analyzed by energy dispersive X-ray spectroscopy (EDX) as shown in Supplementary material Fig. S4. A typical optical microscope image of monolayer  $\text{WSe}_2$  grown on  $\text{SiO}_x$  is shown in Fig. 1c, and its thickness was measured to be  $\sim 0.8 \text{ nm}$  by atomic force microscopy (AFM).

PL and Raman footprint of 1–3 ML  $\text{WSe}_2$  films are investigated to



**Fig. 1.** Growth and characterization of monolayer  $\text{WSe}_2$  directly grown on  $\text{SiO}_x$  templates. (a) *In-situ* observation of RHEED patterns during MBE growth of  $\text{WSe}_2$  monolayer on  $\text{SiO}_x/\text{Si}$  substrates. (b) XPS spectra of W and Se core-level peaks. The atomic percentage ratio of W and Se was determined to be  $\sim 1:2$ . (c) Optical microscope image of bare  $\text{SiO}_x/\text{Si}$  substrate and as-grown  $\text{WSe}_2$  monolayer sample; partial  $\text{WSe}_2$  film was intentionally removed to expose  $\text{SiO}_x$  surface. The insert is an AFM height measurement revealing its thickness of  $\sim 0.8$  nm corresponding to monolayer  $\text{WSe}_2$  film.



**Fig. 2.** Optical properties and crystal structures of 1–3 ML  $\text{WSe}_2$  nanostructures. (a) Micro-photoluminescence spectra of 1–3 ML  $\text{WSe}_2$ ; the gray arrow indicates the reduced energy gap of  $\text{WSe}_2$  with increased thickness. (b) Micro-Raman spectra of 1–3 ML  $\text{WSe}_2$  samples at room temperature;  $E_{2g}$  peak at  $\sim 250.8 \text{ cm}^{-1}$  is the identification of  $\text{WSe}_2$  crystals. (c) Raman mapping of  $E_{2g}$  peak, in  $50 \mu\text{m} \times 50 \mu\text{m}$  region as labeled under optical microscope, where some material was deliberately removed to expose  $\text{SiO}_x$  surface. (d) Schematic atomic configuration of 2H- $\text{WSe}_2$  crystal with layered structure. The dashed hexagon represents the distribution of tungsten atoms. (e) High-resolution plane-view TEM image of  $\text{WSe}_2$  monolayer film. The insert corresponds to selected area electron diffraction pattern. The suspended solid hexagons in (e) represent W atomic distribution of 2H- $\text{WSe}_2$  crystal. (f) Lateral view of multilayer  $\text{WSe}_2$  revealing its layer-by-layer stacking structure.



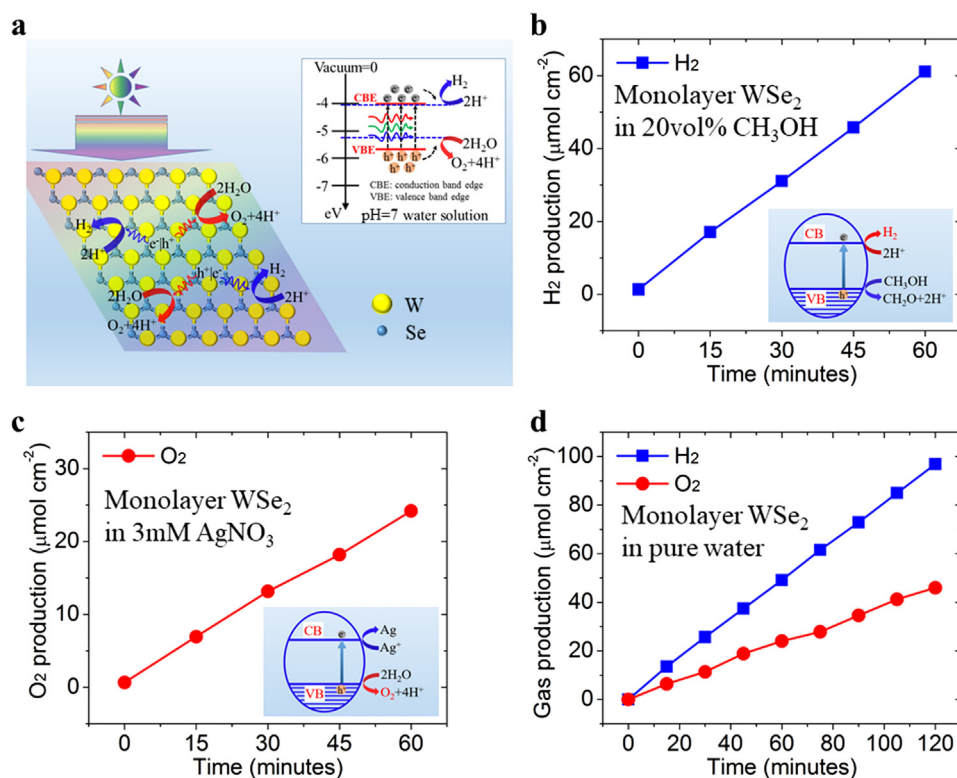
elucidate their optical properties. Fig. 2a compares the PL spectra of 1–3 ML WSe<sub>2</sub> samples measured at room temperature (R.T.). With increasing thickness, the energy bandgap, evidenced by the PL peak position [24,25,39,44], is reduced gradually. The relatively large full-width-at-half-maximum (FWHM,  $\sim 45$  nm) is attributed to the inhomogeneous broadening associated with the presence of defects and grain boundaries. Shown in Fig. 2b are the Raman scattering spectra for WSe<sub>2</sub> samples with different thicknesses. One in-plane vibration mode E<sub>2g</sub> at  $\sim 250.8$  cm<sup>-1</sup> is observed for identifying WSe<sub>2</sub> nanostructures; the shoulder peak A<sub>1g</sub>, representing out-of-plane vibration, at  $\sim 260.2$  cm<sup>-1</sup> is undetected in monolayer sample but is present in thicker layers [42,45]. There are also several weak modes at 350–400 cm<sup>-1</sup> representing second-order vibration [39] for WSe<sub>2</sub> crystals. A typical Raman mapping of E<sub>2g</sub> scattering at  $\sim 250.8$  cm<sup>-1</sup> is shown in Fig. 2c. Some WSe<sub>2</sub> material was intentionally removed to expose SiO<sub>x</sub> surface for better observation under optical microscope.

Monolayer WSe<sub>2</sub> consists of three atom layers where W atom layer is sandwiched between two equivalent Se layers by forming interatomic covalent bonding [22,46]. The atomic structure [27,47] of 2H-phase WSe<sub>2</sub> crystal is schematically depicted in Fig. 2d. Tungsten atoms form face-centered hexagonal pattern [48] and only van der Waals force exists between layers. High-resolution transmission electron microscopy (HR-TEM) was utilized to observe its hexagonal symmetry and layer structure of WSe<sub>2</sub> sample, shown in Fig. 2e and f. The corresponding selected area electron diffraction (SAED) pattern within sixfold symmetry demonstrates that it is a monolayer crystal structure with a hexagonal lattice [22]. Red solid hexagons in Fig. 2e represent the atomic distribution of tungsten in WSe<sub>2</sub> crystal, which reflects a three-fold rotational symmetry in 2H phase. Recent studies have shown that the edge sites of 2H-phase TMDC are catalytically active [13,33]. In this study, during the MBE growth of WSe<sub>2</sub>, a large number of edge sites are spontaneously formed, as shown in Supplementary material Fig. S5, which can provide catalytic functions [33–35]. Fig. 2f reveals the layer-by-layer growth of WSe<sub>2</sub> films. The interlayer spacing is determined to be  $\sim 0.65$  nm for one WSe<sub>2</sub> layer, which is consistent with theoretical calculation and other experimental reports [23,25,29,37]. The atomically smooth layer structure further confirms the vdW epitaxy of WSe<sub>2</sub> grown on amorphous SiO<sub>x</sub> substrates by MBE. Light absorption property of WSe<sub>2</sub>, as presented in Supplementary material Figs. S6 and S7, was examined by ultraviolet-visible spectrophotometry (UV-vis).

Previous studies have suggested that the band edges of monolayer WSe<sub>2</sub> straddles water redox reactions [26–29], schematically illustrated in Fig. 3a. However, it has remained unknown if monolayer WSe<sub>2</sub> possesses the capacity to spontaneously drive proton reduction and water oxidation under sunlight illumination. In this regard, we first performed H<sub>2</sub> and O<sub>2</sub> evolution half-reactions using sacrificial reagents CH<sub>3</sub>OH and AgNO<sub>3</sub>, respectively, shown in Fig. 3b and c. For the H<sub>2</sub> evolution half-reaction, CH<sub>3</sub>OH is sacrificially oxidized by photo-generated holes in the valence band, and photo-generated electrons can reduce H<sup>+</sup> to H<sub>2</sub> at the catalytic edge sites of monolayer WSe<sub>2</sub>. The continuous H<sub>2</sub> evolution under light illumination demonstrates the catalytic capability of proton reduction for monolayer WSe<sub>2</sub> without any other co-catalyst. For O<sub>2</sub> evolution half-reaction, H<sub>2</sub>O molecule is oxidized to produce O<sub>2</sub> gas while the photo-excited electrons reduce Ag<sup>+</sup> to Ag. The continuous O<sub>2</sub> generation shown in Fig. 3c confirms the catalytic ability of water oxidation for monolayer WSe<sub>2</sub>. In these studies, we have performed detailed control experiments on SiO<sub>x</sub>/Si wafer without the presence of monolayer WSe<sub>2</sub>, and no H<sub>2</sub> or O<sub>2</sub> production was measured within the experimental error. The continuous evolution of H<sub>2</sub> and O<sub>2</sub>, shown in Fig. 3b and c, therefore suggests that the conduction and valence band edges of monolayer WSe<sub>2</sub> meet the thermodynamic and kinetic requirements for solar water splitting. This is somewhat surprising, given the relatively narrow energy bandgap ( $\sim 1.65$  eV) of monolayer WSe<sub>2</sub> and small overpotential for proton reduction ( $\sim 0.1$  eV) and water oxidation ( $\sim 0.3$  eV), shown in Fig. 3a. However, in monolayer WSe<sub>2</sub> photocatalyst, charge carrier

generation via photoexcitation and catalytic reaction take place approximately at the same location. As such, photoexcited high-energy electrons and holes can possibly drive proton reduction and water oxidation before cooling to excitons. The resulting hot carrier effect can significantly enhance the photocatalytic activity, which has been reported previously [48–51]. In addition, being in close proximity for the key steps in water splitting reaction, including photoexcitation, charge carrier generation and extraction, and catalytic reaction may enhance the thermodynamic and kinetic coupling of sequential reactions at the nanoscale, which has been a topic being intensively investigated [52–54].

We have subsequently investigated overall solar water splitting on monolayer WSe<sub>2</sub> in pure water (see Section 2.3). Shown in Fig. 3d, the H<sub>2</sub>/O<sub>2</sub> evolution ratio is nearly stoichiometric, in the range of 1.95–2.1, confirming the reaction is direct water splitting. H<sub>2</sub> generation rate is measured to be  $\sim 48.4$   $\mu\text{mol h}^{-1} \text{ cm}^{-2}$  corresponding to  $\sim 0.145\%$  solar-to-hydrogen (STH) conversion efficiency and  $\sim 12.3\%$  absorbed photon conversion efficiency (APCE). Detailed calculations are shown in Supplementary material Note S8. It is noticed that the photon-to-electron conversion efficiency may be limited by non-radiative recombination, due to the presence of defects [55,56]. The reported solar-to-hydrogen conversion efficiency of  $\sim 0.145\%$  on monolayer WSe<sub>2</sub> is compared favorably with the maximum power conversion efficiency ( $\sim 0.2\%$ ) of WSe<sub>2</sub>-MoSe<sub>2</sub> and WSe<sub>2</sub>-WSe<sub>2</sub> p-n junctions reported previously [37,46]. The turnover number, defined as the ratio of the total amount of gas evolved ( $143 \mu\text{mol cm}^{-2}$  for H<sub>2</sub> and O<sub>2</sub>) to the amount of WSe<sub>2</sub> photocatalyst material ( $1.75 \times 10^{-3} \mu\text{mol cm}^{-2}$ ), exceeded 80,000 during the course of  $\sim 2$  h of pure water splitting. We have further investigated the variation of STH efficiency for overall pure water splitting on monolayer WSe<sub>2</sub> as a function of light intensity. Shown in Supplementary material Fig. S8, STH efficiency showed an increasing trend with increasing light intensity, possibly due to the reduced nonradiative recombination at high carrier densities. Similar trends have also been observed in overall pure water splitting on nanowire structures [1]. Finally, when normalized by the volume and mass of the WSe<sub>2</sub> photocatalyst material, the H<sub>2</sub> production rates are estimated to be  $\sim 18,370 \text{ L h}^{-1} \text{ cm}^{-3}$  and  $1972 \text{ L h}^{-1} \text{ g}^{-1}$ , respectively, shown in Supplementary material Fig. S9, which are more than 50 times higher compared to previously best reported photocatalyst ( $1.6 \text{ L h}^{-1} \text{ g}^{-1}$  under  $100 \text{ mW cm}^{-2}$  light) for CoO nanoparticles [57]. As shown in Supplementary material Fig. S10, similar photocatalytic results were also observed for monolayer WSe<sub>2</sub> grown on sapphire substrate. In these studies, careful control experiments were performed on both SiO<sub>x</sub>/Si and sapphire without the presence of monolayer WSe<sub>2</sub>, which did not show any H<sub>2</sub> or O<sub>2</sub> evolution. In addition, Rh/Cr<sub>2</sub>O<sub>3</sub>/CoO<sub>x</sub> nanoparticles as cocatalysts did not significantly improve the photocatalytic performance of monolayer WSe<sub>2</sub>, which could be partly due to the light blocking effect of the co-catalysts. Illustrated in Supplementary material Fig. S10, we have also performed overall water splitting experiments on 2 ML and 3 ML WSe<sub>2</sub> samples, which, however, exhibit negligible photocatalytic activity, possibly due to unsuited energy band alignment for overall water splitting with increasing thicknesses. Photocatalytic stability of 1 ML WSe<sub>2</sub> samples for overall pure water splitting was further studied. There is no significant change of both H<sub>2</sub> and O<sub>2</sub> gas production rate over 8 h, shown in Supplementary material Fig. S11, which suggests that monolayer WSe<sub>2</sub> exhibits a high level of stability. In addition, Raman spectra of 1 ML WSe<sub>2</sub> sample before and after pure water splitting experiments were conducted, as shown in Supplementary Fig. S12, which are nearly identical, indicating monolayer WSe<sub>2</sub> was stable during pure water splitting experiments. As listed in Supplementary material Table S1, the photocatalytic performance of 1 ML WSe<sub>2</sub> was further compared to some previously reported semiconductors for pure water splitting experiments. It is seen that the normalized H<sub>2</sub> evolution rate ( $\text{L h}^{-1} \text{ g}^{-1}$ ) is orders of magnitude higher than previously reported values, showing the extraordinary potential of monolayer materials for solar fuel production.



**Fig. 3.** Solar water splitting measurements of MBE-grown multi-functional monolayer WSe<sub>2</sub> photocatalyst. (a) Schematic illustration of overall water splitting reaction on monolayer WSe<sub>2</sub> without incorporating any co-catalyst. Inset: conduction and valence band edge positions vs. water reduction and water oxidation reactions in pH = 7 water solution. (b) H<sub>2</sub> and (c) O<sub>2</sub> evolution half reactions in the presence of sacrificial reagents, methanol and silver nitrate solutions, respectively, over monolayer WSe<sub>2</sub> under a 300 W full arc xenon lamp illumination with an AM 1.5G filter. (d) Overall photocatalytic water splitting on monolayer WSe<sub>2</sub> under a 300 W xenon lamp irradiation with an AM1.5G optical filter. No degradation of the photocatalytic activity was observed during the course of the reaction.

#### 4. Conclusion

In summary, we have demonstrated the multifunctionality of monolayer WSe<sub>2</sub> in solar water splitting, including extraordinary capacities for efficient light harvesting, water oxidation, and proton reduction. The absorbed photon conversion efficiency exceeds 12% for a single monolayer WSe<sub>2</sub>. We have shown that wafer-scale WSe<sub>2</sub> monolayer sample could be directly grow on amorphous substrates by MBE with precise layer control and can exhibit superb optical properties and catalytic performance. This work provides a viable strategy for wafer-scale synthesis of multi-functional photocatalysts for the development of efficient, low cost, and scalable solar fuel devices and systems.

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#### Conflict of interest

The authors declare no competing financial interests.

#### Appendix A. Supplementary material

Optical images of WSe<sub>2</sub> on SiO<sub>2</sub>/Si substrates, RHEED pattern

during WSe<sub>2</sub> growth on sapphire substrate, EDX, low-magnification TEM, and light absorption characterizations of monolayer WSe<sub>2</sub>, efficiency calculations, normalized hydrogen production, control experiments, stability study, Raman spectra after experiment, and photocatalytic performance comparison with other semiconductors.

Supplementary data associated with this article can be found in the online version at <http://dx.doi.org/10.1016/j.nanoen.2018.06.047>.

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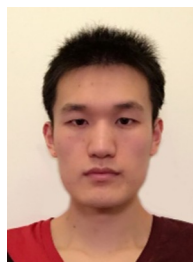
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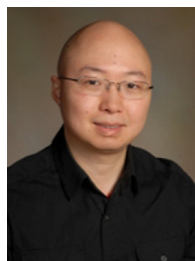
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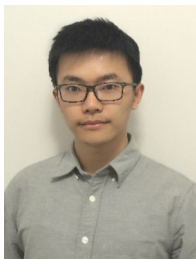
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